Sulfuric Acid 96% CMOS





Material No.: 9684-03 Batch No.: 0000072295 Manufactured Date: 2014/02/17 Retest Date: 2019/02/16

Certificate of Analysis

Test	Specification	Result
Assay (H2SO4)	95.0 - 97.0 %	96.3
Color (APHA)	<= 10	5
Residue after Ignition	<= 2 ppm	< 1
Chloride (Cl)	<= 0.1 ppm	< 0.1
Nitrate (NO3)	<= 0.2 ppm	< 0.1
Phosphate (PO4)	<= 0.3 ppm	< 0.1
Trace Impurities – Aluminum (Al)	<= 50.0 ppb	2.1
Arsenic and Antimony (as As)	<= 5 ppb	< 2
Trace Impurities – Barium (Ba)	<= 10.0 ppb	< 0.2
Trace Impurities – Beryllium (Be)	<= 10.0 ppb	< 0.2
Trace Impurities – Bismuth (Bi)	<= 20.0 ppb	< 1.0
Trace Impurities – Boron (B)	<= 10.0 ppb	< 0.7
Trace Impurities – Cadmium (Cd)	<= 10.0 ppb	< 0.3
Trace Impurities – Calcium (Ca)	<= 50.0 ppb	22.2
Trace Impurities – Chromium (Cr)	<= 50.0 ppb	< 1.0
Trace Impurities – Cobalt (Co)	<= 10.0 ppb	< 0.3
Trace Impurities – Copper (Cu)	<= 10.0 ppb	0.2
Trace Impurities – Gallium (Ga)	<= 10.0 ppb	< 0.2
Trace Impurities - Germanium (Ge)	<= 10.0 ppb	< 2.0
Trace Impurities - Gold (Au)	<= 20.0 ppb	< 1.0
Heavy Metals (as Pb)	<= 200 ppb	< 50
Trace Impurities – Iron (Fe)	<= 100.0 ppb	4.5
Trace Impurities – Lead (Pb)	<= 20.0 ppb	< 0.5
Trace Impurities – Lithium (Li)	<= 10.0 ppb	< 0.2

For questions on this Certificate of Analysis please contact Technical Services at 855.282.6867 or +1.610.573.2600 Avantor ™ Performance Materials Inc.

3477 Corporate Parkway. Suite #200. Center Valley, PA 18034. U.S.A. Phone: 610.573.2600 . Fax: 610.573.2610

Test	Specification	Result
Frace Impurities – Magnesium (Mg)	<= 50.0 ppb	1.0
Frace Impurities – Manganese (Mn)	<= 10.0 ppb	< 0.4
Frace Impurities – Mercury (Hg)	<= 5.0 ppb	< 0.1
Frace Impurities – Molybdenum (Mo)	<= 10.0 ppb	< 3.0
Frace Impurities – Nickel (Ni)	<= 10.0 ppb	< 0.3
Frace Impurities – Niobium (Nb)	<= 10.0 ppb	< 0.2
Frace Impurities – Potassium (K)	<= 50.0 ppb	2.0
Frace Impurities – Silicon (Si)	<= 50.0 ppb	6.0
race Impurities – Silver (Ag)	<= 10.0 ppb	< 0.3
Frace Impurities – Sodium (Na)	<= 100.0 ppb	25.9
Frace Impurities – Strontium (Sr)	<= 10.0 ppb	< 0.2
Frace Impurities – Tantalum (Ta)	<= 10.0 ppb	< 0.9
Frace Impurities – Thallium (Tl)	<= 20.0 ppb	< 2.0
Frace Impurities – Tin (Sn)	<= 50.0 ppb	<1
Frace Impurities – Titanium (Ti)	<= 10.0 ppb	0.9
Frace Impurities – Vanadium (V)	<= 10.0 ppb	< 0.2
Frace Impurities – Zinc (Zn)	<= 50.0 ppb	4.0
Frace Impurities – Zirconium (Zr)	<= 10.0 ppb	< 0.1
Particle Count – 0.5 µm and greater	<= 60 par/ml	16
Particle Count - 1.0 µm and greater	<= 10 par/ml	6

For Microelectronic Use

Storage Conditions:Recommended Storage Conditions: 15° – 100°FCountry of Origin:USPackaging Site:Paris Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004 Paris, KY 9001:2008 Mexico City, Mexico 9001:2008 Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003 Gliwice, Poland 9001:2008, 17025:2005 Selangor, Malaysia 9001:2008, 14001:2004, 13485:2003 Mumbai, India, 9001:2008, 17025:2005 Panoli, India 9001:2008

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Richard M Siberski Vice President Global Quality

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